UNISONIC TECHNOLOGIES CO., LTD

8N60K-MTQ Power MOSFET

8A, 600V N-CHANNEL **POWER MOSFET**

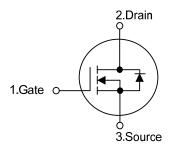
DESCRIPTION

The UTC 8N60K-MTQ is a high voltage and high current power MOSFET, designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient AC to DC converters and bridge circuits.

FEATURES

- * $R_{DS(ON)} \le 1.4\Omega$ @ V_{GS} =10V, I_D =4.0A
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness

SYMBOL



TO-220F TO-220 TO-220F2 TO-220F1

ORDERING INFORMATION

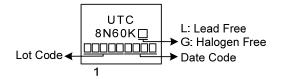
Ordering Number		Dookogo	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
8N60KL-TA3-T	8N60KG-TA3-T	TO-220	G	D	S	Tube	
8N60KL-TF1-T	8N60KG-TF1-T	TO-220F1	G	D	S	Tube	
8N60KL-TF2-T	8N60KG-TF2-T	TO-220F2	G	D	S	Tube	
8N60KL-TF3-T	8N60KG-TF3-T	TO-220F	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



www.unisonic.com.tw 1 of 7

MARKING





8N60K-MTQ Power MOSFET

■ **ABSOLUTE MAXIMUM RATINGS** (T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V _{DSS}	600	V
Gate-Source Voltage		V_{GSS}	±30	V
Drain Current	Continuous	I _D 8		Α
	Pulsed (Note 2)	I _{DM} 32		Α
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	306	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.5	V/ns
Power Dissipation	TO-220		147	W
	TO-220F/TO-220F1 TO-220F2	P _D	48	W
Junction Temperature		TJ	+150	°C
Operating Temperature		T _{OPR}	-55 ~ + 150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 20mH, I_{AS} = 5.6A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C
- 4. $I_{SD} \le 7.5 A$, di/dt $\le 200 A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25 ^{\circ}C$

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient		θ_{JA}	62.5	°C/W
	TO-220		0.85	°C/W
	TO-220F/TO-220F1 TO-220F2	θ _{JC}	2.6	°C/W



ELECTRICAL CHARACTERISTICS (T_C =25°C, unless otherwise specified)

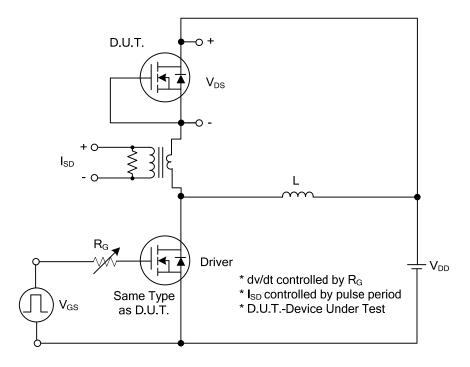
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							•
Drain-Source Breakdown Voltage		BV _{DSS}	V _{GS} = 0 V, I _D = 250 μA	600			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} = 600 V, V _{GS} = 0V			10	μΑ
Gate-Source Leakage Current	Forward	I _{GSS}	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{V}$			100	nA
	Reverse		$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
Breakdown Voltage Temperature Coefficient		$\triangle BV_{DSS}/\triangle T_{J}$	I _D =250μA, Referenced to 25°C		0.7		V/°C
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	$V_{GS} = 10V, I_D = 4A$			1.4	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance	nput Capacitance				540		pF
Output Capacitance		C _{ISS}	$V_{DS} = 25V, V_{GS} = 0V, f = 1MHz$		95		pF
Reverse Transfer Capacitance		C _{RSS}			10		pF
SWITCHING CHARACTERISTIC	S						
Total Gate Charge		Q_G	V _{DS} =50V, V _{GS} =10V, I _D =1.3A		22.8		nC
Gate-Source Charge		Q_GS	I _G =100µA (Note 1, 2)		6.6		nC
Gate-Drain Charge		Q_GD	IG-100μΑ (Note 1, 2)		5.7		nC
Turn-On Delay Time		t _{D(ON)}			56		ns
Turn-On Rise Time		t_R	$V_{DD} = 30V, V_{GS} = 10V, I_D = 0.5A,$		65		ns
Turn-Off Delay Time		t _{D(OFF)}	R _G =25Ω (Note 1, 2)		118.5		ns
Turn-Off Fall Time		t_{F}			62		ns
DRAIN-SOURCE DIODE CHARA	CTERISTIC	CS AND MAXII	MUM RATINGS				
Maximum Continuous Drain-Source Diode		Is				8	Α
Forward Current						o	^
Maximum Pulsed Drain-Source Diode		I _{SM}				32	Α
Forward Current						52	
Drain-Source Diode Forward Voltage		V_{SD}	$V_{GS} = 0V, I_S = 8A$			1.4	V

Notes: 1. Pulse Test: Pulse width \leq 300 μ s, Duty cycle \leq 2%.

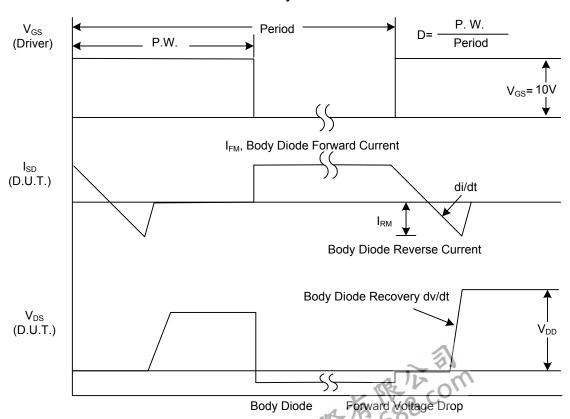
2. Essentially independent of operating temperature.



■ TEST CIRCUITS AND WAVEFORMS

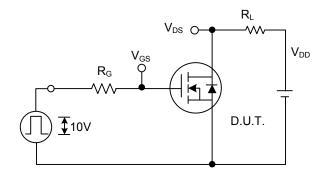


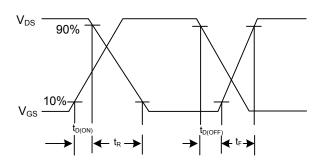
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dwdt Waveforms

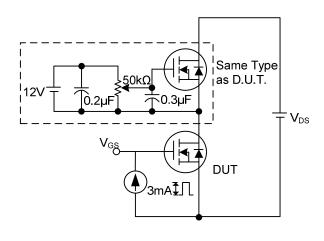
TEST CIRCUITS AND WAVEFORMS

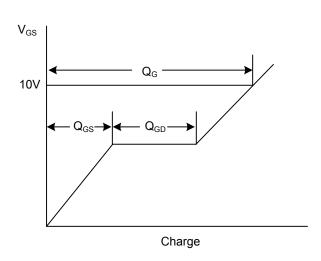




Switching Test Circuit

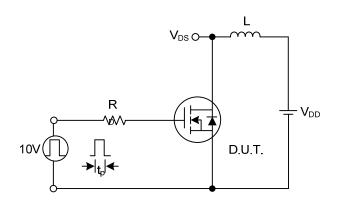
Switching Waveforms

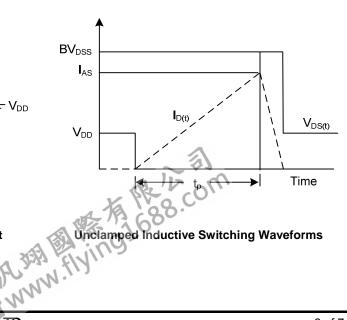




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

UTC assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all UTC products described or contained herein. UTC products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. UTC reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

